

IN THE CLAIMS

Please amend the claims as follows:

Claim 1 (Currently Amended): A method of reclaiming silicon wafers, comprising:
in the following order, a film removal process; a heating/removal process; a polishing process; and a cleaning process; ~~and a heating/removal process~~ wherein the heating/removal process is between the film removal process and the polishing process,
wherein the heating/removal process comprises heating the silicon wafer at 150-300 °C for 20 minutes to 5 hours and removing a surface part of the silicon wafer.

Claim 2 (Previously Presented): The method of reclaiming silicon wafers according to claim 1, wherein the heating/removal process comprises a mechanical removal process.

Claim 3 (Previously Presented): The method of reclaiming silicon wafers according to claim 1, wherein the heating/removal process comprises a chemical removal process.

Claim 4 (Currently Amended): The method of reclaiming silicon wafers according to claim 3, wherein the chemical removal process is performed using ~~alkali~~ alkaline hydroxides and/or ~~alkali~~ alkaline carbonates.

Claim 5 (Previously Presented): The method of reclaiming silicon wafers according to claim 1, wherein the method comprises both
an immersion process comprising chemically processing the silicon wafer with a chemical processing liquid; and

the heating/removal process comprising heating the silicon wafer at 150-300 °C for 20 minutes to 5 hours and removing a surface part of the silicon wafer between the film removal process and the polishing process.

Claim 6 (Currently Amended): The method of reclaiming silicon wafers according to claim 5, wherein the chemical processing liquid comprises:

a hydrogen peroxide aqueous solution; a mixed solution of a hydrogen peroxide aqueous solution, an ammonia aqueous solution, and water;

a mixed solution of a hydrogen peroxide aqueous solution, hydrochloric acid, and water; alkali alkaline hydroxide aqueous solution; or

an alkali alkaline carbonate aqueous solution.

Claim 7 (Previously Presented): The method of reclaiming silicon wafers according to claim 5, wherein the heating/removal process comprises a mechanical removal process.

Claim 8 (Previously Presented): The method of reclaiming silicon wafers according to claim 5, wherein the heating/removal process comprises a chemical removal process.

Claim 9 (Currently Amended): The method of reclaiming silicon wafers according to claim 8, wherein the chemical removal process is performed using alkali alkaline hydroxides and/or alkali alkaline carbonates.

Claim 10 (Previously Presented): The method of reclaiming silicon wafers according to claim 6, wherein the heating/removal process comprises a mechanical removal process.

Claim 11 (Previously Presented): The method of reclaiming silicon wafers according to claim 6, wherein the heating/removal process comprises a chemical removal process.

Claim 12 (Currently Amended): The method of reclaiming silicon wafers according to claim 11, wherein the chemical removal is performed using ~~alkali~~ alkaline hydroxides and/or ~~alkali~~ alkaline carbonates.

Claim 13 (Currently Amended): The method of reclaiming silicon wafers according to claim 12, wherein the ~~alkali~~ alkaline hydroxide and/or carbonate are selected from a group consisting of potassium hydroxide, potassium carbonate, sodium hydroxide, sodium carbonate, and quaternary alkyl ammonium hydroxides.

Claim 14 (New): The method according to claim 1, wherein the heating/removal process does not form any oxygen donors.

Claim 15 (New): The method according to claim 1, wherein the heating/removal process is carried out in air.

Claim 16 (New): The method according to claim 1, wherein the maximum temperature is 300°C.

Claim 17 (New): The method according to claim 1, wherein the heating/removal process is carried out to provide a silicon wafer having the same specific resistance of a virgin silicon wafer.

Claim 18 (New): The method according to claim 1, wherein the heating/removal process does not vary the specific resistance of a P-type or N-type silicon wafer.